

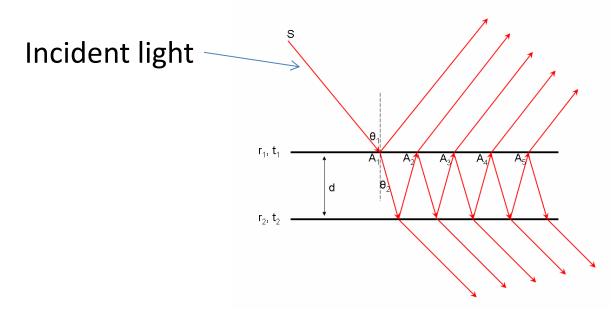
Physics 42200 Waves & Oscillations

Lecture 37 – Interference

Spring 2016 Semester

Matthew Jones

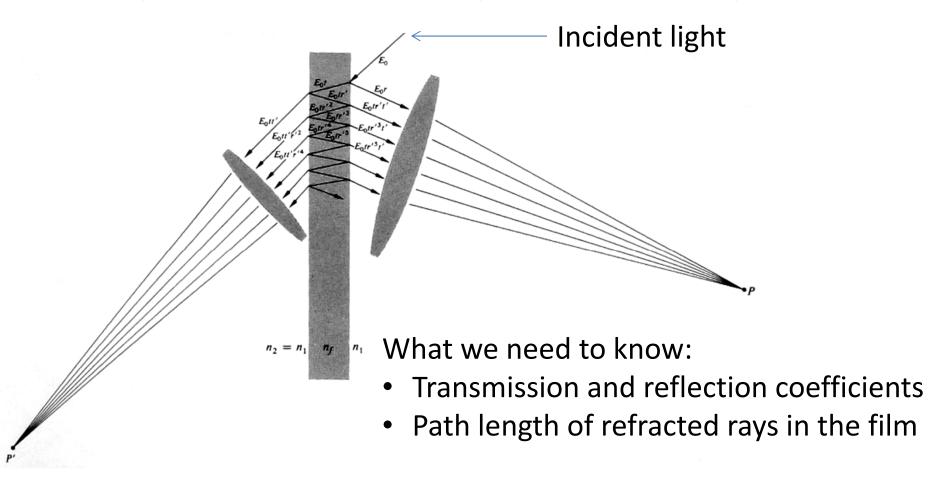
- In many situations, a coherent beam can interfere with itself multiple times
- Consider a beam incident on a thin film
 - Some component of the light will be reflected at each surface and some will be transmitted



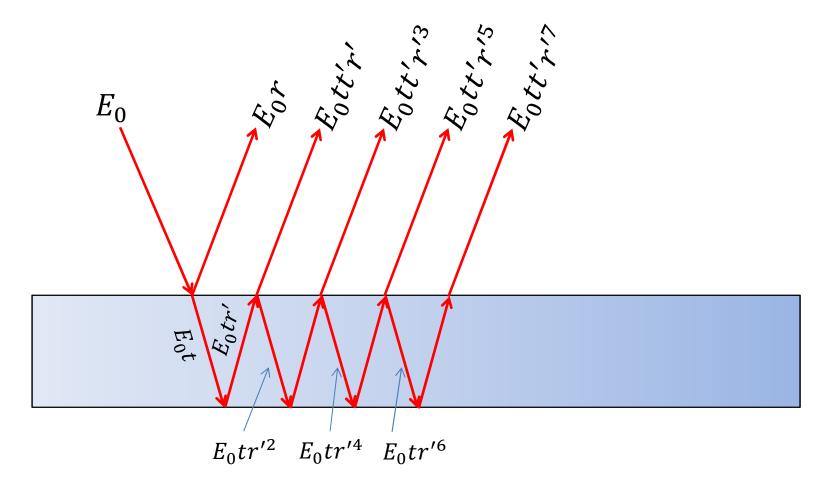
Each transmitted beam will have a different phase relative to the adjacent beams.

What is the total intensity of the reflected light?

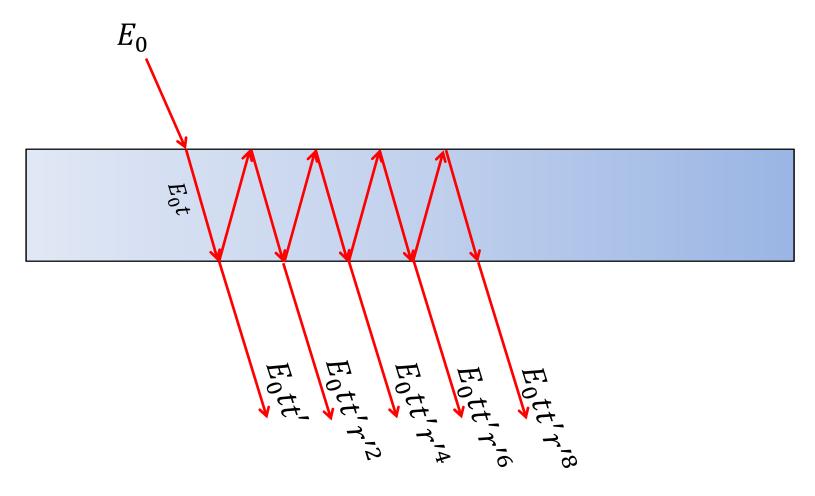
- All transmitted and reflected rays will be parallel
- They can be focused onto points P and P' by lenses:



- Reflection coefficients: r and r'
- Transmission coefficients: t and t'



- Reflection coefficients: r and r'
- Transmission coefficients: t and t'



The additional phase in the film is always the same:

$$\delta = \frac{2nkd}{\cos\theta_t}$$

If the initial phase is zero, then

$$E_{1r} = E_0 r e^{i\omega t}$$

$$E_{2r} = E_0 t t' r' e^{i(\omega t - \delta)}$$

$$E_{3r} = E_0 t t' r'^3 e^{i(\omega t - 2\delta)}$$

$$E_{4r} = E_0 t t' r'^5 e^{i(\omega t - 3\delta)}$$

• • •

In general:

$$E_{Nr} = E_0 e^{i\omega t} t t' r'^{2N-3} e^{-i(N-1)\delta}$$
$$= E_0 e^{i\omega t} t t' r' e^{-i\delta} (r'^2 e^{-i\delta})^{N-2}$$

The total electric field on one side of the film:

$$E_{r} = E_{0}e^{i\omega t}r + E_{0}e^{i\omega t}tt'r'e^{-i\delta} \times \left[1 + r'^{2}e^{-i\delta} + (r'^{2}e^{-i\delta})^{2} + (r'^{2}e^{-i\delta})^{3} + \cdots\right]$$

This is in infinite sum of the form:

$$\sum_{n=0}^{\infty} z^n = \frac{1}{1-z} \quad \text{(when } |z| < 1)$$

Total electric field:

$$E_r = E_0 e^{i\omega t} \left[r + \frac{tt'r'e^{-i\delta}}{1 - r'^2 e^{-i\delta}} \right]$$

Simplifications:

$$r' = -r$$
$$tt' = 1 - r^2$$

Total electric field:

$$E_{r} = E_{0}e^{i\omega t}r \left[1 - \frac{(1 - r^{2})e^{-i\delta}}{1 - r^{2}e^{-i\delta}} \right]$$

$$= E_{0}e^{i\omega t}r \left[\frac{1 - r^{2}e^{-i\delta} - e^{-i\delta} + r^{2}e^{-i\delta}}{1 - r^{2}e^{-i\delta}} \right]$$

$$= E_{0}e^{i\omega t}r \left[\frac{1 - e^{-i\delta}}{1 - r^{2}e^{-i\delta}} \right]$$

• The intensity of the light is $I_r \propto |E_r|^2$

$$I_{r} = I_{0} \left\{ r \left[\frac{1 - e^{-i\delta}}{1 - r^{2}e^{-i\delta}} \right] \right\}^{*} \left\{ r \left[\frac{1 - e^{-i\delta}}{1 - r^{2}e^{-i\delta}} \right] \right\}$$

$$= I_{0}r^{2} \frac{(1 - e^{i\delta})(1 - e^{-i\delta})}{(1 - r^{2}e^{i\delta})(1 - r^{2}e^{-i\delta})}$$

$$= I_{0} \frac{2r^{2}(1 - \cos\delta)}{(1 + r^{4}) - 2r^{2}\cos\delta}$$

• The intensity of the transmitted light is $I_t \propto |E_t|^2$

$$I_t = I_0 \frac{1 - r^2}{(1 + r^4) - 2r^2 \cos \delta}$$

One more identity will clean this up a bit:

$$\cos \delta = 1 - 2\sin^2(\delta/2)$$

Reflected intensity:

$$I_r = I_0 \frac{F \sin^2(\delta/2)}{1 + F \sin^2(\delta/2)}$$

• Transmitted intensity:

$$I_t = I_0 \frac{1}{1 + F \sin^2(\delta/2)}$$

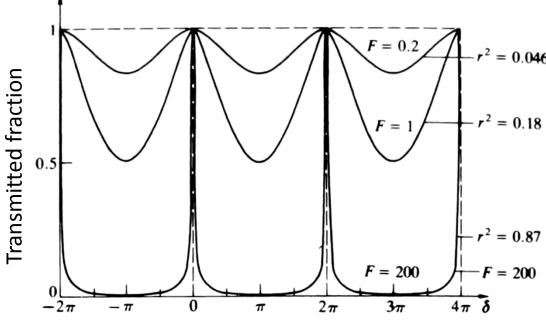
- The parameter $F = \left(\frac{2r}{1-r^2}\right)^2$ is called the *coefficient of finesse*
- Notice that $I_0 = I_r + I_t$
 - We assumed that no energy was lost in the film

The function

$$\mathcal{A}(\theta) = \frac{1}{1 + F \sin^2(\delta/2)}$$

is called the Airy function.

Remember that 8 is a Remember that 8 is a Remember the angle of the angle function of incidence, 0.



- In practice, some fraction of the light will be absorbed
- Absorptance, *A*, is defined by:

$$T + R + A = 1$$

This modifies the transmitted intensity:

$$I_t = I_0 \left[1 - \frac{A}{1 - R} \right]^2 \mathcal{A}(\theta)$$

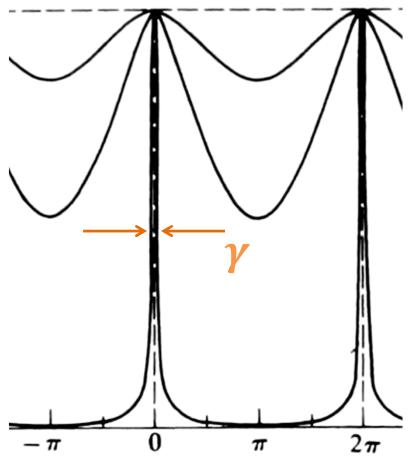
• Example: silver film, 50 nm thick, deposited on glass

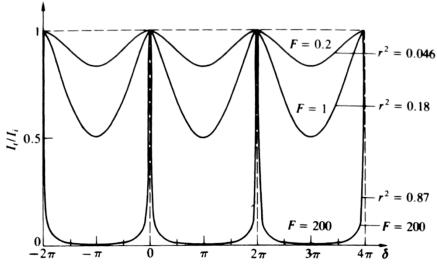
$$R = 0.94, T = 0.01, A = 0.05$$

$$\left[1 - \frac{A}{1 - R}\right]^{2} = 0.0278$$

$$F = 1044$$

How sharp are the peaks?





Width of one line:

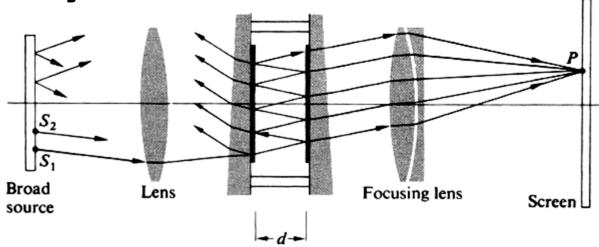
$$\gamma = 4/\sqrt{F}$$

Ratio of line spacing to the width:

$$\mathcal{F} = \frac{2\pi}{\gamma} = \frac{\pi\sqrt{F}}{2}$$

"Finesse" \mathcal{F} , not to be confused with the "coefficient of finesse" F.

Previous example: $\mathcal{F} \approx 50$



Phase difference:

$$\delta = \frac{4\pi n_f}{\lambda_0} d\cos\theta_i = 2\pi m$$
$$m\lambda_0 = 2n_f d\cos\theta_i$$

• Differentiate: $m~\Delta\lambda_0 + \Delta m~\lambda_0 = 0$ $\frac{\Delta m}{m} = -\frac{\Delta\lambda_0}{\lambda}$

$$\frac{\lambda_0}{\Delta \lambda_0} = \frac{2\pi m}{\Delta \delta}$$

Smallest resolvable wavelength difference:

$$(\Delta \lambda_0)_{min} = \frac{\lambda_0 (\Delta \delta)_{min}}{2\pi m}$$

Minimum resolvable phase shift:

$$(\Delta \delta)_{min} \sim \gamma = 4/\sqrt{F}$$

Chromatic resolving power:

$$\mathcal{R} = \frac{\lambda_0}{(\Delta \lambda_0)_{min}} \approx \mathcal{F} m \approx \mathcal{F} \frac{2n_f d}{\lambda_0}$$

Typical values:

$$\mathcal{F} = 50$$

$$n_f d = 1 cm$$

$$\lambda_0 = 500 nm$$

$$\mathcal{R} = \frac{2 \times 50 \times 1 cm}{500 nm} = 2 \times 10^6$$

Diffraction grating

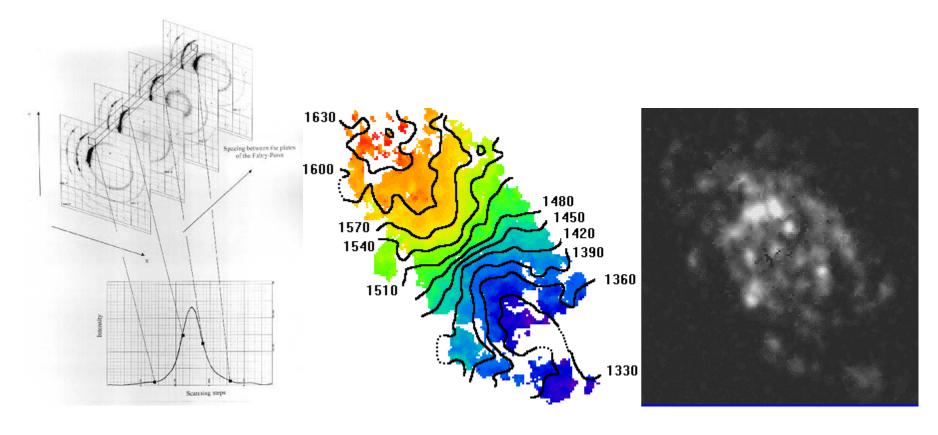


Michelson interferometer

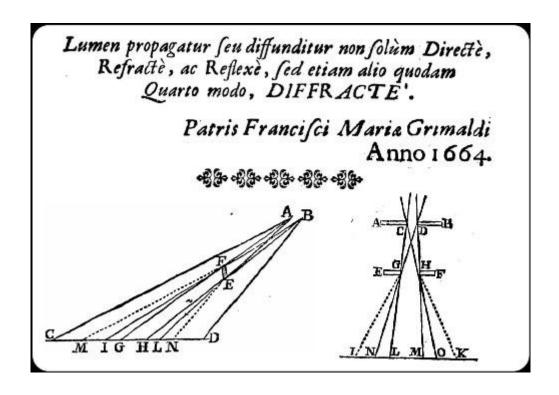


Fabry-Perot interferometer

 The effective gap between the surfaces can be adjusted by changing the pressure of a gas, or by means of piezoelectric actuators

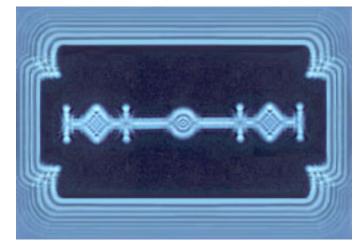


Diffraction



"Light transmitted or diffused, not only directly, refracted, and reflected, but also in some other way in the fourth, *breaking*."





Huygens-Fresnel Principle

Huygens:

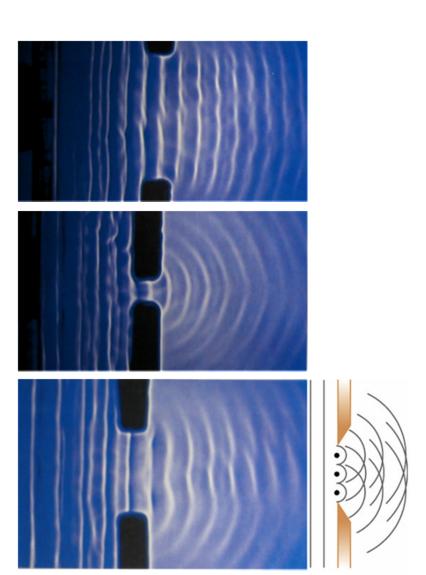
 Every point on a wave front acts as a point source of secondary spherical waves that have the same phase as the original wave at that point.

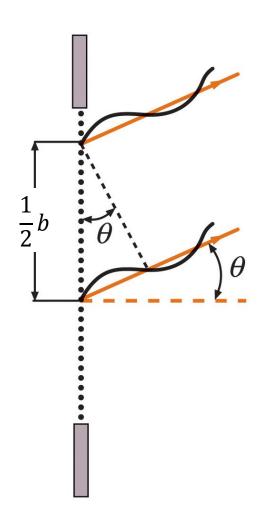
Fresnel:

 The amplitude of the optical field at any point in the direction of propagation is the superposition of all wavelets, considering their amplitudes and relative phases.

Examples with water waves

- Wide slit: waves are unaffected
- Narrow slit: source of spherical waves
- In between: multiple interfering point sources





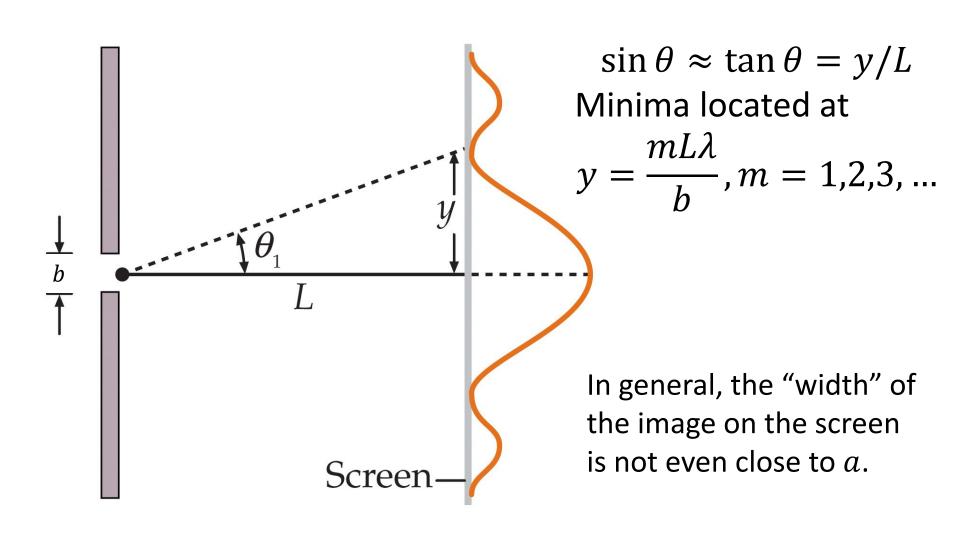
Think of the slit as a number of point sources with equal amplitude. Divide the slit into two pieces and think of the interference between light in the upper half and light in the lower half.

Destructive interference when

$$\frac{b}{2}\sin\theta = \frac{\lambda}{2}$$

Minima when

$$\sin\theta = \frac{\lambda}{b}$$





Minima located at

$$\sin \theta = \frac{mL\lambda}{b}$$
, $m = 1,2,3,...$

Minima only occur when $b > \lambda$.

Intensity

Waves from all points in the slit travel the same distance to reach the center and are in phase: constructive interference.

$$\frac{\lambda}{a}$$

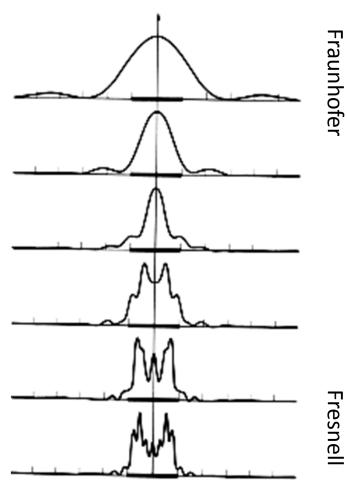
$$\frac{2\lambda}{a}$$

Fresnel and Fraunhofer Diffraction

Assumptions about the wave front that impinges on the slit:

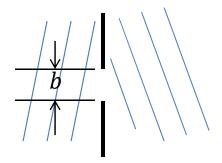
 When it's a plane, the phase varies linearly across the slit: Fraunhofer diffraction

 When the phase of the wave front has significant curvature: Fresnel diffraction



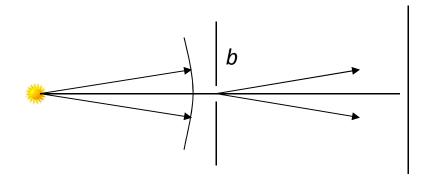
Fresnel and Fraunhofer Diffraction

- Fraunhofer diffraction
 - Far field: $R \gg b^2/\lambda$

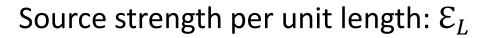


R is the smaller of the distance to the source or to the screen

- Fresnel Diffraction:
 - Near field: wave front is not a plane at the aperture

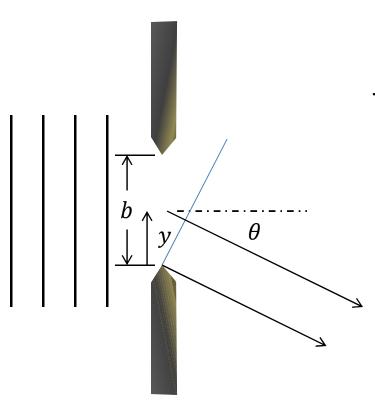


Light with intensity I_0 impinges on a slit with width b



Electric field at a distance R due to the length element dy:

$$dE = \frac{\mathcal{E}_L e^{i\delta(y)} dy}{R}$$
$$\delta(y) = ky \sin \theta$$



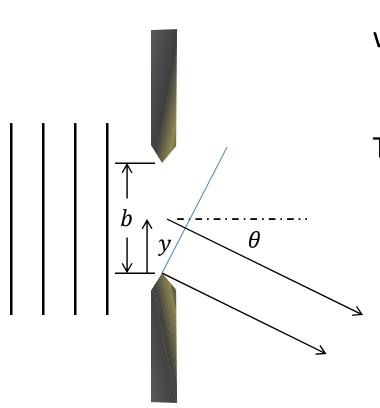
$$dE = \frac{\mathcal{E}_L e^{iky \sin \theta} dy}{R}$$

Let y = 0 be at the center of the slit. Integrate from -b/2 to +b/2: Total electric field:

$$E = \frac{\mathcal{E}_L}{R} \int_{-b/2}^{+b/2} e^{iky \sin \theta} dy$$

$$= \frac{\mathcal{E}_L}{R} \frac{e^{i(kb/2) \sin \theta} - e^{-i(kb/2) \sin \theta}}{ik \sin \theta}$$

$$= \frac{\mathcal{E}_L b}{R} \frac{\sin \left(\frac{1}{2}kb \sin \theta\right)}{\frac{1}{2}kb \sin \theta}$$



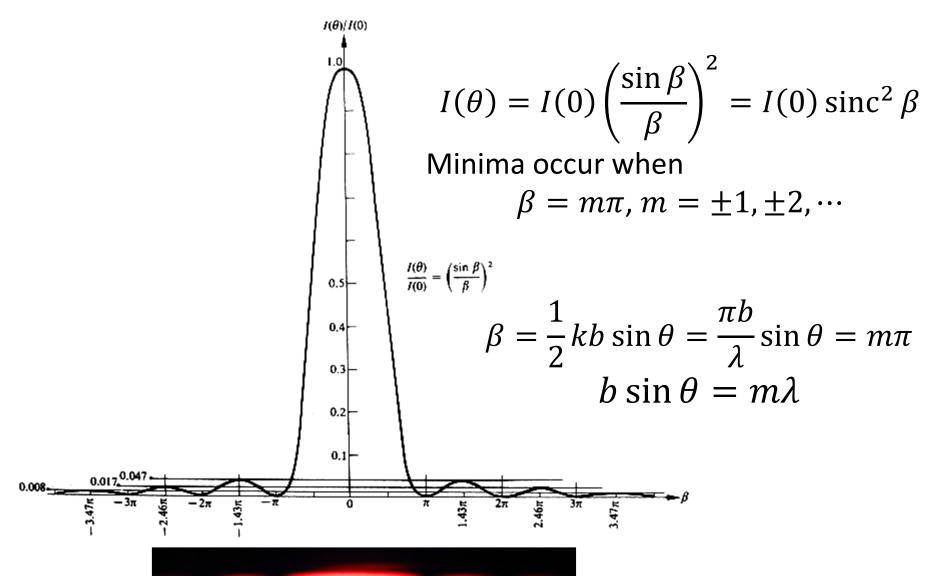
$$E = \frac{\mathcal{E}_L b}{R} \frac{\sin \beta}{\beta}$$

where

$$\beta = \frac{1}{2}kb\sin\theta$$

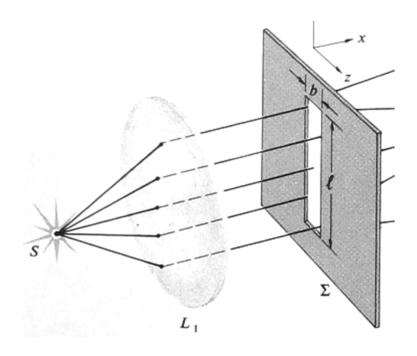
The intensity of the light will be

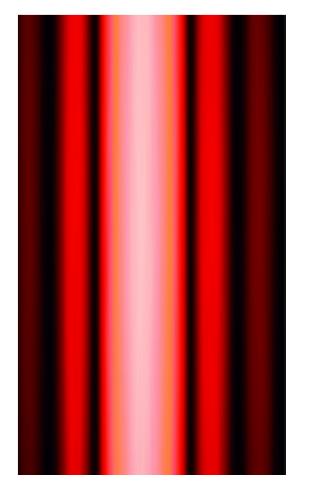
$$I(\theta) = I(0) \left(\frac{\sin \beta}{\beta}\right)^{2}$$
$$= I(0) \operatorname{sinc}^{2} \beta$$



Single slit: Fraunhofer diffraction

Adding dimension: long narrow slit Diffraction most prominent in the narrow direction.





Emerging light has cylindrical symmetry

Rectangular Aperture Fraunhofer Diffraction

Source strength per unit area: \mathcal{E}_A

$$dE \approx \frac{\mathcal{E}_L e^{ikyY/R} e^{ikzZ/R} dy dz}{R}$$

$$E = \frac{\mathcal{E}_L}{R} \left(\int_{-b/2}^{+b/2} e^{ikyY/R} dy \right) \left(\int_{-a/2}^{+a/2} e^{ikzZ/R} dz \right)$$

$$I(Y,Z) = I(0) \left(\frac{\sin \beta'}{\beta'} \right)^2 \left(\frac{\sin \alpha'}{\alpha'} \right)^2$$

Rectangular Aperture

